Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/787,314	BAYNE ET AL.
Examiner	Art Unit
Pia F. Tibbits	2838

SEARCHED				
Class	Subclass	Date	Examiner	
1801	2-2			
			,	
<u> </u>				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east-interference	5/2/06	PT
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